


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586424	<b>Applicant(s)/Patent Under Reexamination</b>  ZAPPE ET AL.
	<b>Examiner</b>  Sophia S Chen	<b>Art Unit</b>  2852

SEARCHED			
Class	Subclass	Date	Examiner
399	302, 308, 303, 313, 66, 306	3/3/2010	/SC/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGUPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) - See search history printout	3/4/2010	/SC/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
N/A			

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